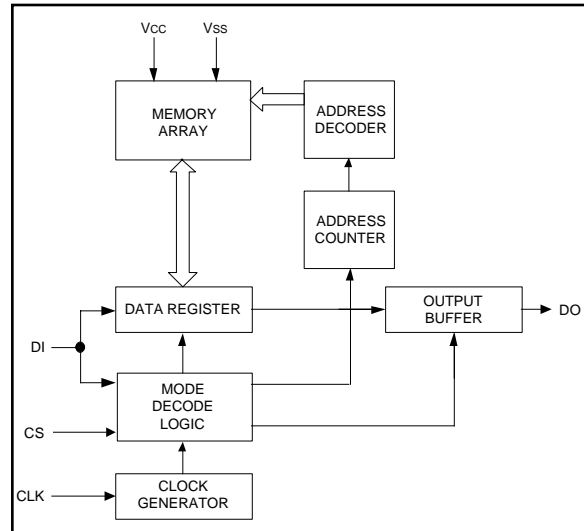![Microchip logo] **MICROCHIP**

93LC46/56/66

1K/2K/4K 2.0V Microwire® Serial EEPROM

FEATURES

- Single supply with programming operation down to 2.0V (Commercial only)
- Low power CMOS technology
  - 1 mA active current typical
  - 5 µA standby current (typical) at 3.0V
- ORG pin selectable memory configuration
  - 128 x 8 or 64 x 16-bit organization (93LC46)
  - 256 x 8 or 128 x 16-bit organization (93LC56)
  - 512 x 8 or 256 x 16-bit organization (93LC66)
- Self-timed ERASE and WRITE cycles (including auto-erase)
- Automatic ERAL before WRAL
- Power on/off data protection circuitry
- Industry standard 3-wire serial I/O
- Device status signal during ERASE/WRITE cycles
- Sequential READ function
- 10,000,000 ERASE/WRITE cycles guaranteed on 93LC56 and 93LC66
- 1,000,000 E/W cycles guaranteed on 93LC46
- Data retention > 200 years
- 8-pin PDIP/SOIC and 14-pin SOIC package (SOIC in JEDEC and EIAJ standards)
- Temperature ranges supported
  - Commercial (C):   0°C to   +70°C
 - Industrial (I):   -40°C to   +85°C

BLOCK DIAGRAM

DESCRIPTION

The Microchip Technology Inc. 93LC46/56/66 are 1K, 2K, and 4K low-voltage serial Electrically Erasable PROMs. The device memory is configured as x8 or x16 bits, depending on the ORG pin setup. Advanced CMOS technology makes these devices ideal for low-power, nonvolatile memory applications. The 93LC46/56/66 is available in standard 8-pin DIP and 8/14-pin surface mount SOIC packages. The 93LC46X/56X/66X are only offered in an "SN" package.

PACKAGE TYPES
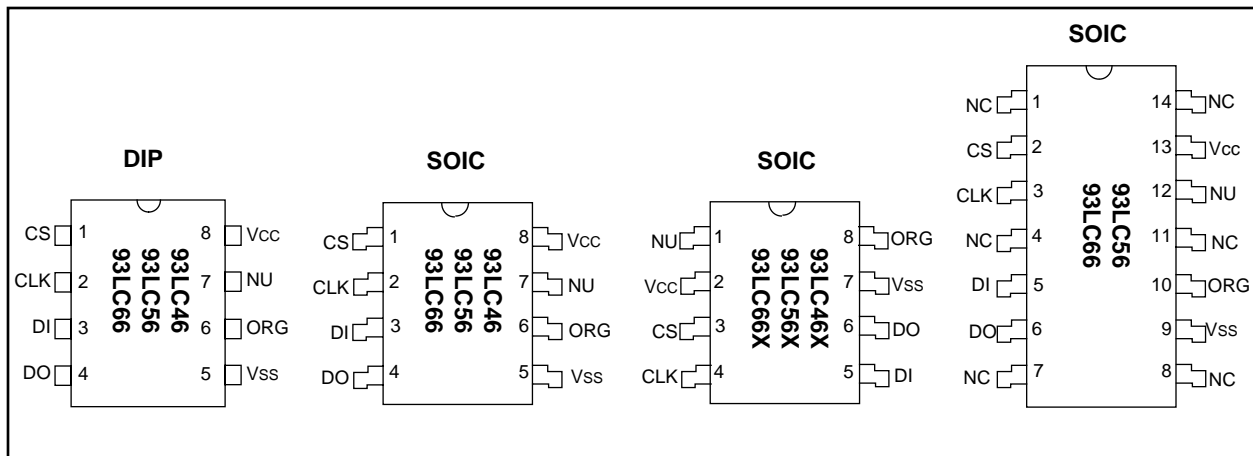
93LC46/56/66

1.0 ELECTRICAL CHARACTERISTICS

1.1 Maximum Ratings*

Vcc 7.0V
All inputs and outputs w.r.t. Vss .... -0.6V to Vcc +1.0V
Storage temperature .... -65˚C to +150˚C
Ambient temp. with power applied.................. -65˚C to +125˚C
Soldering temperature of leads (10 seconds) .... +300˚C
ESD protection on all pins..4 kV

*Notice: Stresses above those listed under "Maximum ratings" may
cause permanent damage to the device. This is a stress rating only and
functional operation of the device at those or any other conditions
above those indicated in the operational listings of this specification is
not implied. Exposure to maximum rating conditions for extended peri-
ods may affect device reliability.

PIN function Table

Name	Function
CS	Chip Select
CLK	Serial Data Clock
DI	Serial Data Input
DO	Serial Data Output
Vss	Ground
ORG	Memory Configuration
NU	Not Utilized
NC	No Connect
Vcc	Power Supply

TABLE 1-1 DC AND AC ELECTRICAL CHARACTERISTICS

		Commercial (C): Vcc = +2.0V to +6.0V (C): Tamb = 0˚C to +70˚C			
		Industrial (I): Vcc = +2.5V to +6.0V (I): Tamb = -40˚C to +85˚C			
Parameter	Symbol	Min.	Max.	Units	Conditions
High level input voltage	V_{IH1}	2.0	Vcc +1	V	$V_{CC} \geq 2.7V$
	V_{IH2}	0.7 Vcc	Vcc +1	V	$V_{CC} < 2.7V$
Low level input voltage	V_{IL1}	-0.3	0.8	V	$V_{CC} \geq 2.7V$
	V_{IL2}	-0.3	0.2 Vcc	V	$V_{CC} < 2.7V$
Low level output voltage	V_{OL1}	—	0.4	V	I_{OL} = 2.1 mA; Vcc = 4.5V
	V_{OL2}	—	0.2	V	I_{OL} =100 µA; Vcc = Vcc Min.
High level output voltage	V_{OH1}	2.4	—	V	I_{OH} = -400 µA; Vcc = 4.5V
	V_{OH2}	Vcc-0.2	—	V	I_{OH} = -100 µA; Vcc = Vcc Min.
Input leakage current	I_{LI}	-10	10	µA	V_{IN} = 0.1V to Vcc
Output leakage current	I_{LO}	-10	10	µA	V_{OUT} = 0.1V to Vcc
Pin capacitance (all inputs/outputs)	C_{IN}, C_{OUT}	—	7	pF	V_{IN}/V_{OUT} = 0 V (Notes 1 & 3) Tamb = +25°C, F_{CLK} = 1 MHz
Operating current	I_{CC} read	—	1	mA	F_{CLK} = 2 MHz; Vcc = 6.0V
			500	µA	F_{CLK} = 1 MHz; Vcc = 3.0V
	I_{CC} write	—	3	mA	F_{CLK} = 2 MHz; Vcc = 6.0V (Note 3)
Standby current	I_{CCS}	—	100	µA	CLK = CS = 0V; Vcc = 6.0V
			30	µA	CLK = CS = 0V; Vcc = 3.0V
Clock frequency	F_{CLK}	—	2	MHz	Vcc ≥ 4.5V
			1	MHz	Vcc < 4.5V
Clock high time	T_{CKH}	250	—	ns	
Clock low time	T_{CKL}	250	—	ns	
Chip select setup time	T_{CSS}	50	—	ns	Relative to CLK
Chip select hold time	T_{CSH}	0	—	ns	Relative to CLK
Chip select low time	T_{CSL}	250	—	ns	
Data input setup time	T_{DIS}	100	—	ns	Relative to CLK
Data input hold time	T_{DIH}	100	—	ns	Relative to CLK
Data output delay time	T_{PD}	—	400	ns	C_L = 100 pF
Data output disable time	T_{CZ}	—	100	ns	C_L = 100 pF (Note 3)
Status valid time	T_{SV}	—	500	ns	C_L = 100 pF
Program cycle time	T_{WC}	—	10	ms	ERASE/WRITE mode (Note 2)
	T_{EC}	—	15	ms	ERAL mode
	T_{WL}	—	30	ms	WRAL mode
Endurance 93LC46	—	1M	—	cycles	25°C, Vcc = 5.0V, Block Mode (Note 4)
93LC56/66	—	10M	—		

Note 1: This parameter is tested at Tamb = 25˚C and F_{CLK} = 1 MHz.
  2: Typical program cycle time is 4 ms per word.
  3: This parameter is periodically sampled and not 100% tested.
  4: This application is not tested but guaranteed by characterization. For endurance estimates in a specific applica-
     tion, please consult the Total Endurance Model which can be obtained on our BBS or website.

2.0   PIN DESCRIPTION

2.1   Chip Select (CS)

A high level selects the device. A low level deselects the device and forces it into standby mode. However, a programming cycle which is already initiated and/or in progress will be completed, regardless of the CS input signal. If CS is brought low during a program cycle, the device will go into standby mode as soon as the programming cycle is completed.

CS must be low for 250 ns minimum (T_{CSL}) between consecutive instructions. If CS is low, the internal control logic is held in a RESET status.

2.2   Serial Clock (CLK)

The Serial Clock (CLK) is used to synchronize the communication between a master device and the 93LCXX. Opcodes, addresses, and data bits are clocked in on the positive edge of CLK. Data bits are also clocked out on the positive edge of CLK.

CLK can be stopped anywhere in the transmission sequence (at high or low level) and can be continued anytime with respect to clock high time (T_{CKH}) and clock low time (T_{CKL}). This gives the controlling master freedom in preparing the opcode, address, and data.

CLK is a "Don't Care" if CS is low (device deselected). If CS is high, but the START condition has not been detected, any number of clock cycles can be received by the device without changing its status (i.e., waiting for a START condition).

CLK cycles are not required during the self-timed WRITE (i.e., auto ERASE/WRITE) cycle.

After detecting a START condition, the specified number of clock cycles (respectively low to high transitions of CLK) must be provided. These clock cycles are required to clock in all required opcodes, addresses, and data bits before an instruction is executed (Table 2-1 to Table 2-6). CLK and DI then become don't care inputs waiting for a new START condition to be detected.

> **Note:** CS must go low between consecutive instructions.

2.3   Data In (DI)

Data In (DI) is used to clock in a START bit, opcode, address, and data synchronously with the CLK input.

2.4   Data Out (DO)

Data Out (DO) is used in the READ mode to output data synchronously with the CLK input (T_{PD} after the positive edge of CLK).

This pin also provides READY/$\overline{BUSY}$ status information during ERASE and WRITE cycles. READY/$\overline{BUSY}$ status information is available on the DO pin if CS is brought high after being low for minimum chip select low time (T_{CSL}) and an ERASE or WRITE operation has been initiated.

The status signal is not available on DO, if CS is held low or high during the entire WRITE or ERASE cycle. In all other cases DO is in the HIGH-Z mode. If status is checked after the ERASE/WRITE cycle, a pull-up resistor on DO is required to read the READY signal.

2.5   Organization (ORG)

When ORG is tied to V_{SS}, the (x8) memory organization is selected. When ORG is connected to V_{CC} or floated, the (x16) memory organization is selected. ORG can only be floated for clock speeds of 1 MHz or less for the (X16) memory organization. For clock speeds greater than 1 MHz, ORG must be tied to V_{CC} or V_{SS}.

93LC46/56/66

TABLE 2-1   INSTRUCTION SET FOR 93LC46: ORG = 0 (X 8 ORGANIZATION)

Instruction	SB	Opcode	Address	Data In	Data Out	Req. CLK Cycles
ERASE	1	11	A6 A5 A4 A3 A2 A1 A0	—	(RDY/$\overline{\text{BSY}}$)	10
ERAL	1	00	1 0 X X X X X	—	(RDY/$\overline{\text{BSY}}$)	10
EWDS	1	00	0 0 X X X X X	—	HIGH-Z	10
EWEN	1	00	1 1 X X X X X	—	HIGH-Z	10
READ	1	10	A6 A5 A4 A3 A2 A1 A0	—	D7 - D0	18
WRITE	1	01	A6 A5 A4 A3 A2 A1 A0	D7 - D0	(RDY/$\overline{\text{BSY}}$)	18
WRAL	1	00	0 1 X X X X X	D7 - D0	(RDY/$\overline{\text{BSY}}$)	18

TABLE 2-2   INSTRUCTION SET FOR 93LC46: ORG = 1 (X 16 ORGANIZATION)

Instruction	SB	Opcode	Address	Data In	Data Out	Req. CLK Cycles
ERASE	1	11	A5 A4 A3 A2 A1 A0	—	(RDY/$\overline{\text{BSY}}$)	9
ERAL	1	00	1 0 X X X X	—	(RDY/$\overline{\text{BSY}}$)	9
EWDS	1	00	0 0 X X X X	—	HIGH-Z	9
EWEN	1	00	1 1 X X X X	—	HIGH-Z	9
READ	1	10	A5 A4 A3 A2 A1 A0	—	D15 - D0	25
WRITE	1	01	A5 A4 A3 A2 A1 A0	D15 - D0	(RDY/$\overline{\text{BSY}}$)	25
WRAL	1	00	0 1 X X X X	D15 - D0	(RDY/$\overline{\text{BSY}}$)	25

TABLE 2-3   INSTRUCTION SET FOR 93LC56: ORG = 0 (X 8 ORGANIZATION)

Instruction	SB	Opcode	Address	Data In	Data Out	Req. CLK Cycles
ERASE	1	11	X A7 A6 A5 A4 A3 A2 A1 A0	—	(RDY/$\overline{\text{BSY}}$)	12
ERAL	1	00	1 0 X X X X X X X	—	(RDY/$\overline{\text{BSY}}$)	12
EWDS	1	00	0 0 X X X X X X X	—	HIGH-Z	12
EWEN	1	00	1 1 X X X X X X X	—	HIGH-Z	12
READ	1	10	X A7 A6 A5 A4 A3 A2 A1 A0	—	D7 - D0	20
WRITE	1	01	X A7 A6 A5 A4 A3 A2 A1 A0	D7 - D0	(RDY/$\overline{\text{BSY}}$)	20
WRAL	1	00	0 1 X X X X X X X	D7 - D0	(RDY/$\overline{\text{BSY}}$)	20

TABLE 2-4   INSTRUCTION SET FOR 93LC56: ORG = 1 (X 16 ORGANIZATION)

Instruction	SB	Opcode	Address	Data In	Data Out	Req. CLK Cycles
ERASE	1	11	X A6 A5 A4 A3 A2 A1 A0	—	(RDY/$\overline{\text{BSY}}$)	11
ERAL	1	00	1 0 X X X X X X	—	(RDY/$\overline{\text{BSY}}$)	11
EWDS	1	00	0 0 X X X X X X	—	HIGH-Z	11
EWEN	1	00	1 1 X X X X X X	—	HIGH-Z	11
READ	1	10	X A6 A5 A4 A3 A2 A1 A0	—	D15 - D0	27
WRITE	1	01	X A6 A5 A4 A3 A2 A1 A0	D15 - D0	(RDY/$\overline{\text{BSY}}$)	27
WRAL	1	00	0 1 X X X X X X	D15 - D0	(RDY/$\overline{\text{BSY}}$)	27

TABLE 2-5   INSTRUCTION SET FOR 93LC66: ORG = 0 (X 8 ORGANIZATION)

Instruction	SB	Opcode	Address	Data In	Data Out	Req. CLK Cycles
ERASE	1	11	A8 A7 A6 A5 A4 A3 A2 A1 A0	—	(RDY/$\overline{\text{BSY}}$)	12
ERAL	1	00	1 0 X X X X X X X	—	(RDY/$\overline{\text{BSY}}$)	12
EWDS	1	00	0 0 X X X X X X X	—	HIGH-Z	12
EWEN	1	00	1 1 X X X X X X X	—	HIGH-Z	12
READ	1	10	A8 A7 A6 A5 A4 A3 A2 A1 A0	—	D7 - D0	20
WRITE	1	01	A8 A7 A6 A5 A4 A3 A2 A1 A0	D7 - D0	(RDY/$\overline{\text{BSY}}$)	20
WRAL	1	00	0 1 X X X X X X X	D7 - D0	(RDY/$\overline{\text{BSY}}$)	20

TABLE 2-6   INSTRUCTION SET FOR 93LC66: ORG = 1 (X 16 ORGANIZATION)

Instruction	SB	Opcode	Address	Data In	Data Out	Req. CLK Cycles
READ	1	10	A7 A6 A5 A4 A3 A2 A1 A0	—	D15 - D0	27
EWEN	1	00	1 1 X X X X X	—	High-Z	11
ERASE	1	11	A7 A6 A5 A4 A3 A2 A1 A0	—	(RDY/$\overline{\text{BSY}}$)	11
ERAL	1	00	1 0 X X X X X	—	(RDY/$\overline{\text{BSY}}$)	11
WRITE	1	01	A7 A6 A5 A4 A3 A2 A1 A0	D15 - D0	(RDY/$\overline{\text{BSY}}$)	27
WRAL	1	00	0 1 X X X X X	D15 - D0	(RDY/$\overline{\text{BSY}}$)	27
EWDS	1	00	0 0 X X X X X	—	High-Z	11

3.0 FUNCTIONAL DESCRIPTION

When it is connected to ground, the (x8) organization is selected. When the ORG pin is connected to Vcc, the (x16) organization is selected. Instructions, addresses and write data are clocked into the DI pin on the rising edge of the clock (CLK). The DO pin is normally held in a HIGH-Z state, except when reading data from the device or when checking the READY/BUSY status during a programming operation. The READY/BUSY status can be verified during an ERASE/WRITE operation by polling the DO pin; DO low indicates that programming is still in progress, while DO high indicates the device is ready. The DO will enter the HIGH-Z state on the falling edge of the CS.

3.1 START Condition

The START bit is detected by the device if CS and DI are both high with respect to the positive edge of CLK for the first time.

Before a START condition is detected, CS, CLK, and DI may change in any combination (except to that of a START condition), without resulting in any device operation (READ, WRITE, ERASE, EWEN, EWDS, ERAL, and WRAL). As soon as CS is high, the device is no longer in the standby mode.

An instruction following a START condition will only be executed if the required amount of opcodes, addresses, and data bits for any particular instruction is clocked in.

After execution of an instruction (i.e., clock in or out of the last required address or data bit) CLK and DI become don't care bits until a new START condition is detected.

3.2 Data In (DI) and Data Out (DO)

It is possible to connect the Data In (DI) and Data Out (DO) pins together. However, with this configuration, if A0 is a logic-high level, it is possible for a "bus conflict" to occur during the "dummy zero" that precedes the READ operation. Under such a condition the voltage level seen at DO is undefined and will depend upon the relative impedances of Data Out, and the signal source driving A0. The higher the current sourcing capability of A0, the higher the voltage at the DO pin.

3.3 Data Protection

During power-up, all programming modes of operation are inhibited until Vcc has reached a level greater than 1.4V. During power-down, the source data protection circuitry acts to inhibit all programming modes when Vcc has fallen below 1.4V at nominal conditions.

The ERASE/WRITE Disable (EWDS) and ERASE/WRITE Enable (EWEN) commands give additional protection against accidentally programming during normal operation.

After power-up, the device is automatically in the EWDS mode. Therefore, an EWEN instruction must be performed before any ERASE or WRITE instruction can be executed.

FIGURE 3-1:   SYNCHRONOUS DATA TIMING

93LC46/56/66
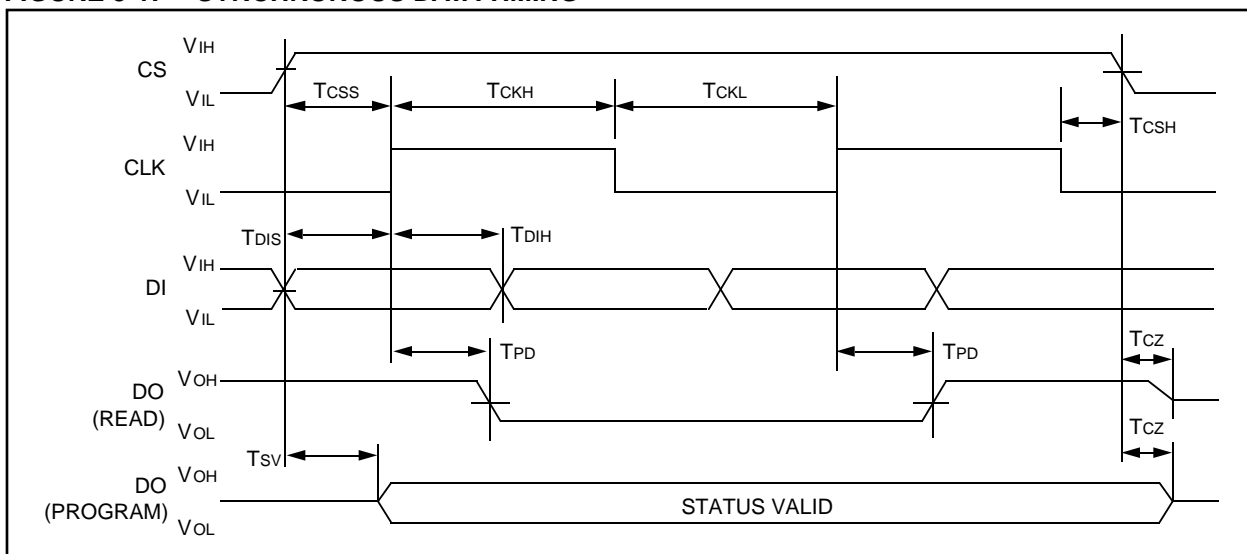
3.4   ERASE

The ERASE instruction forces all data bits of the specified address to the logical "1" state. CS is brought low following the loading of the last address bit. This falling edge of the CS pin initiates the self-timed programming cycle.

The DO pin indicates the READY/$\overline{BUSY}$ status of the device if CS is brought high after a minimum of 250 ns low (T$_{CSL}$). DO at logical "0" indicates that programming is still in progress. DO at logical "1" indicates that the register at the specified address has been erased and the device is ready for another instruction.

The ERASE cycle takes 4 ms per word (Typical).

3.5   Erase All (ERAL)

The Erase All (ERAL) instruction will erase the entire memory array to the logical "1" state. The ERAL cycle is identical to the ERASE cycle except for the different opcode. The ERAL cycle is completely self-timed and commences at the falling edge of the CS. Clocking of the CLK pin is not necessary after the device has entered the self clocking mode. The ERAL instruction is guaranteed at Vcc = +4.5V to +6.0V.

The DO pin indicates the READY/$\overline{BUSY}$ status of the device if CS is brought high after a minimum of 250 ns low (T$_{CSL}$) and before the entire write cycle is complete.

The ERAL cycle takes 15 ms maximum (8 ms typical).

FIGURE 3-2:   ERASE TIMING

FIGURE 3-3:   ERAL TIMING

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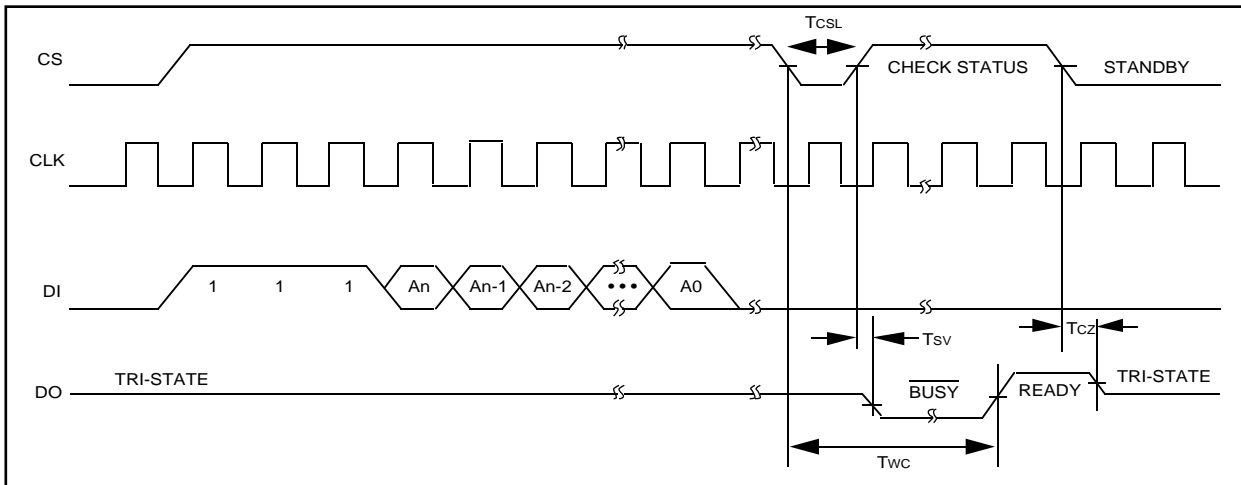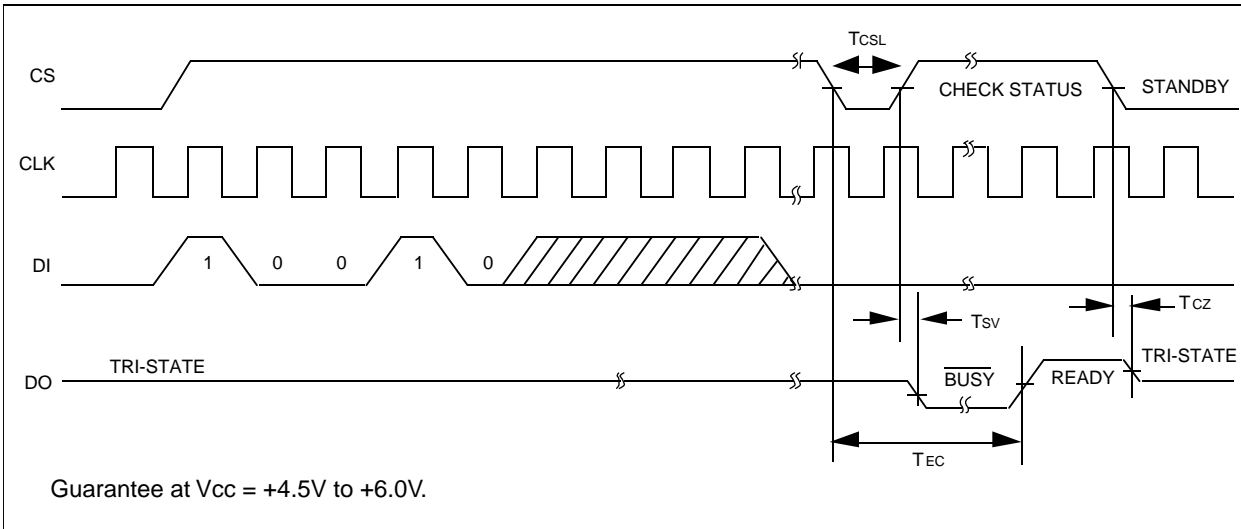
3.6 ERASE/WRITE Disable and Enable (EWEN, EWDS)

The 93LC46/56/66 powers up in the ERASE/WRITE Disable (EWDS) state. All programming modes must be preceded by an ERASE/WRITE Enable (EWEN) instruction. Once the EWEN instruction is executed, programming remains enabled until an EWDS instruction is executed or V_{CC} is removed from the device. To protect against accidental data disturb, the EWDS instruction can be used to disable all ERASE/WRITE functions and should follow all programming operations. Execution of a READ instruction is independent of both the EWDS and EWEN instructions.

3.7 READ

The READ instruction outputs the serial data of the addressed memory location on the DO pin. A dummy zero bit precedes the 8-bit (x8 organization) or 16-bit (x16 organization) output string. The output data bits will toggle on the rising edge of the CLK and are stable after the specified time delay (T_{PD}.). Sequential read is possible when CS is held high. The memory data will automatically cycle to the next register and output sequentially.

FIGURE 3-4: EWDS TIMING
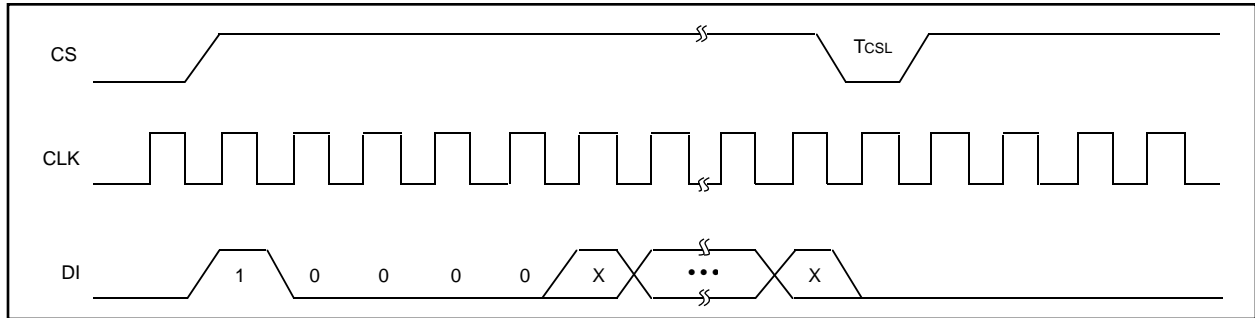
FIGURE 3-5: EWEN TIMING

FIGURE 3-6: READ TIMING

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93LC46/56/66
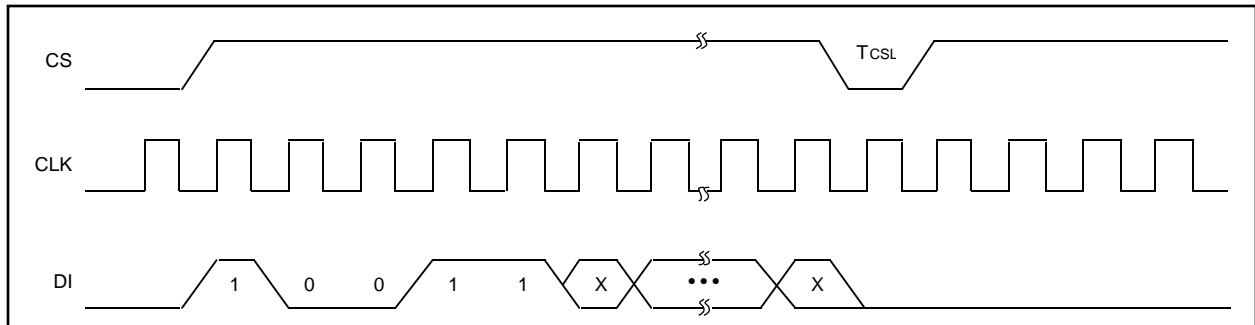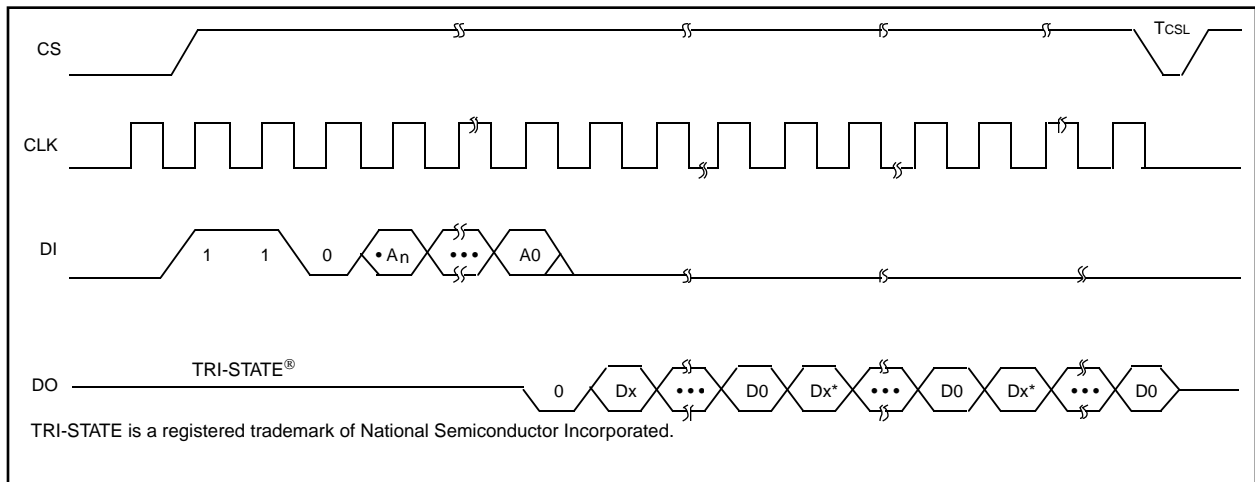
3.8 WRITE

The WRITE instruction is followed by 8 bits (or by 16 bits) of data which are written into the specified address. After the last data bit is put on the DI pin, CS must be brought low before the next rising edge of the CLK clock. This falling edge of CS initiates the self-timed auto-erase and programming cycle.

The DO pin indicates the READY/$\overline{\text{BUSY}}$ status of the device, if CS is brought high after a minimum of 250 ns low (T$_{CSL}$) and before the entire write cycle is complete. DO at logical "0" indicates that programming is still in progress. DO at logical "1" indicates that the register at the specified address has been written with the data specified and the device is ready for another instruction.

The WRITE cycle takes 4 ms per word (Typical).

3.9 Write All (WRAL)

The Write All (WRAL) instruction will write the entire memory array with the data specified in the command. The WRAL cycle is completely self-timed and commences at the falling edge of the CS. Clocking of the CLK pin is not necessary after the device has entered the self clocking mode. The WRAL command does include an automatic ERAL cycle for the device. Therefore, the WRAL instruction does not require an ERAL instruction, but the chip must be in the EWEN status. The WRAL instruction is guaranteed at V$_{CC}$ = +4.5V to +6.0V.

The DO pin indicates the READY/$\overline{\text{BUSY}}$ status of the device if CS is brought high after a minimum of 250 ns low (T$_{CSL}$).

The WRAL cycle takes 30 ms maximum (16 ms typical).

FIGURE 3-7: WRITE TIMING

FIGURE 3-8: WRAL TIMING

Guarantee at Vcc = +4.5V to +6.0V.
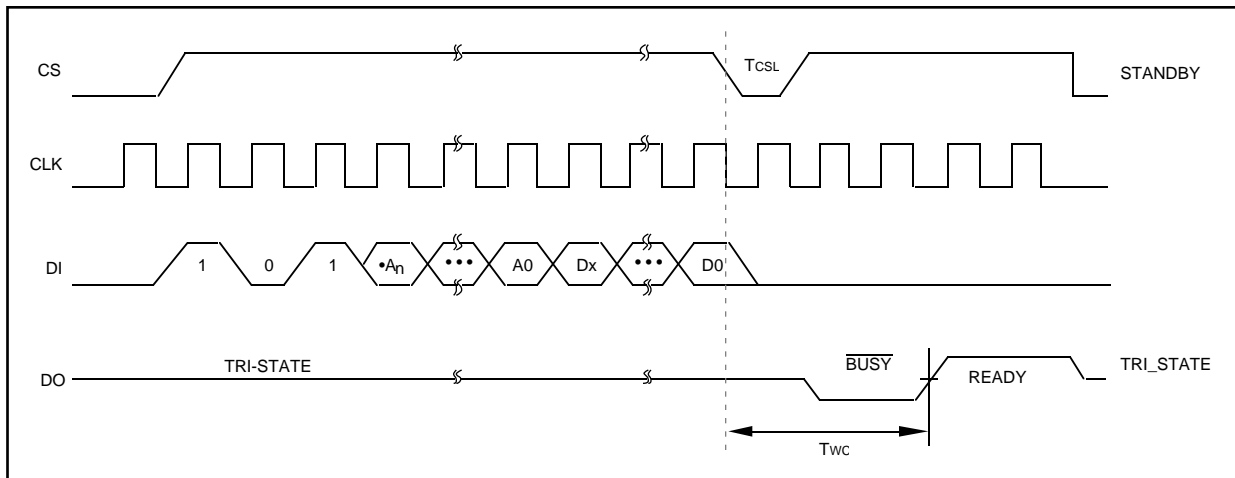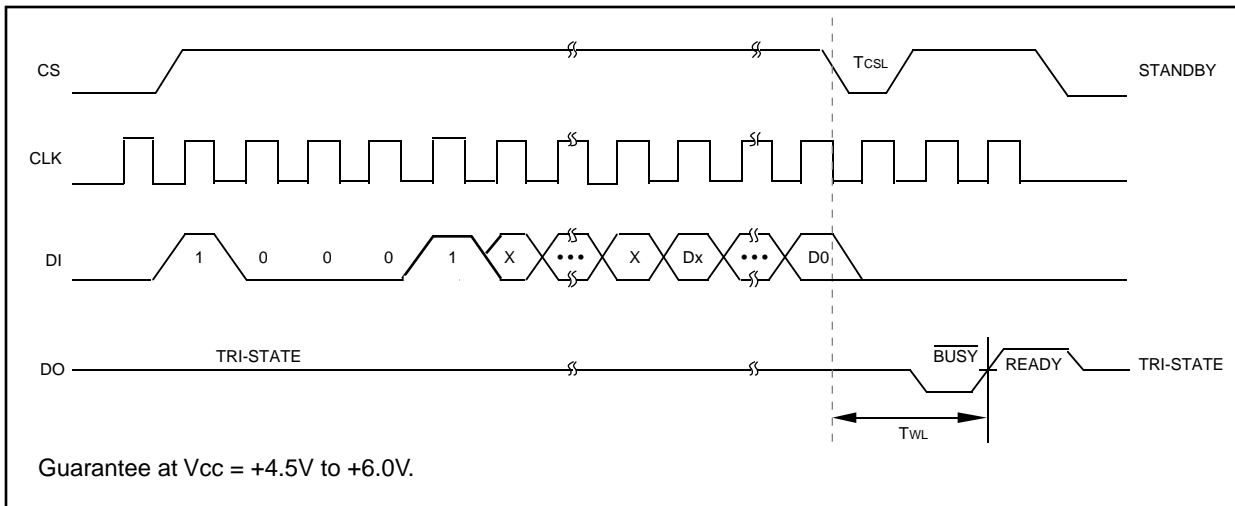
NOTES:

NOTES:

93LC46/56/66 PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office..

93LC46/56/66 — __ /P

Package:

P = Plastic DIP (300 mil Body), 8-lead
SL = Plastic SOIC (107 mil Body), 14-lead
SN = Plastic SOIC (150 mil Body), 8-lead
SM = Plastic SOIC (207 mil Body), 8-lead

Temperature Range:

Blank = 0˚C to +70˚C
I = −40˚C to +85˚C

Device:

93LC46	1K Microwire Serial EEPROM
93LC46T	1K Microwire Serial EERPOM, Tape and Reel
93LC46X	1K Microwire Serial EEPROM in alternate pinouts (SN package only)
93LC46XT	1K Microwire Serial EEPROM in alternate pinouts, Tape and Reel (SN package only)
93LC56	2K Microwire Serial EEPROM
93LC56T	2K Microwire Serial EERPOM, Tape and Reel
93LC56X	2K Microwire Serial EEPROM in alternate pinouts (SN package only)
93LC56XT	2K Microwire Serial EEPROM in alternate pinouts, Tape and Reel (SN package only)
93LC66	4K Microwire Serial EEPROM
93LC66T	4K Microwire Serial EERPOM, Tape and Reel
93LC66X	4K Microwire Serial EEPROM in alternate pinouts (SN package only)
93LC66XT	4K Microwire Serial EEPROM in alternate pinouts, Tape and Reel (SN package only)

Sales and Support

Data Sheets
Products supported by a preliminary Data Sheet may have an errata sheet describing minor operational differences and recommended workarounds. To determine if an errata sheet exists for a particular device, please contact one of the following:
1. Your local Microchip sales office
2. The Microchip Corporate Literature Center U.S. FAX: (602) 786-7277
3. The Microchip's Bulletin Board, via your local CompuServe number (CompuServe membership NOT required).

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